

**Notice of References Cited**

Application/Control No.

09/643,276

Applicant(s)/Patent Under  
Reexamination  
KOJIMA ET AL.

Examiner

Oanh L. Duong

Art Unit

2155

Page 1 of 1

IDC-US Ref -8

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0115277	06-2003	WATANABE et al.	709/207
	B	US-2001/0042093	11-2001	SHIRAI et al.	709/201
	C	US-2002/0059362	05-2002	MAEDA, TORU	709/203
	D	US- <del>6,041,689</del> 6,014,689	01-2000	Budge, et al	709/206
	E	US-6,553,374	04-2003	Yamamoto et al.	707/9
	F	US-6,192,396	02-2001	Kohler, Timothy L.	709/206
	G	US-6,073,133	06-2000	Chrabaszcz, Michael P.	707/10
	H	US-6,545,768	04-2003	Matsubara et al.	358/1.15
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

mas  
6/19/06

IDC-For Ref -1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000339239 A	12-2000	Japan	KATO, SHINICHIRO	G06F 13/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.